

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L4	6325	((GaN (gallium adj nitride)) near5 (substrate wafer) and epitax\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/15 16:57
L6	20	I5 and ((contamination contaminant residue) near4 (metal))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/15 17:02
L7	0	I5 and (light adj emitting adj diode)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/15 17:04
L8	1880	I5 and (light adj emitting adj diode)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/15 17:04
S87	134	(contamination contaminant residue) with (emission emitting emit) with density	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 15:57
S88	31	S87 and (LED (light adj emitting adj diode))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 15:59
S89	110	((contamination contaminant residue) with metal with ((light adj emitting adj diode) (LED)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 16:13

S90	54	S89 and @ad<="20031027"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 16:58
S91	2166	((contamination contaminant residue impurities impurity) with metal) and (light adj emitting adj diode)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:18
S92	1115	S91 and @ad<="20031027"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:18
S93	7	((contamination contaminant residue impurities impurity) with metal with (brightness intensity)) and (light adj emitting adj diode)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:19
S94	1090	((contamination contaminant residue impurities impurity) with metal) and (light adj emitting adj diode) and (brightness intensity)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:20
S95	572	S94 and @ad<="20031027"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:20
S96	7	((contamination contaminant residue impurities impurity) with metal) with (brightness intensity)) and (light adj emitting adj diode)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:53
S97	300	((contamination contaminant residue impurities impurity) with metal) with (brightness intensity)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:54

S98	187	S97 and @ad<="20031027"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/10 17:54
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